

### **FEATURES**

Low noise density, 0.015°/sec/√Hz 300°/sec dynamic range Z-axis, yaw rate response Calibrated offset and sensitivity 320 Hz bandwidth, adjustable 35 ms turn-on time Digital self-test High vibration rejection High shock survivability Embedded temperature sensor output Precision voltage reference output 5 V single-supply operation -40°C to +85°C

### **APPLICATIONS**

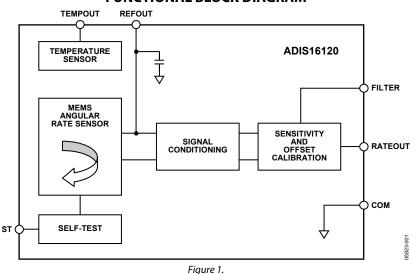
Guidance and control Instrumentation Inertial measurement units (IMU) Stabilization

### **GENERAL DESCRIPTION**

The ADIS16120 is a low noise, angular rate sensor (gyroscope) that includes all of the necessary embedded signal conditioning to provide a low noise, analog output over the complete dynamic range of  $\pm 300^{\circ}$ /sec. Factory calibration provides excellent offset and gain accuracy. The unique design implementation provides superior stability over variations in temperature, voltage, linear acceleration, vibration, and next level assembly. The surface-micromachining manufacturing technology is the same high volume BiMOS process used by Analog Devices, Inc. for its high reliability automotive sensor products.

The output signal, RATEOUT, is a voltage proportional to the angular rate about the axis normal to the top surface of the package. A precision reference and a temperature output are provided for system level calibrations and a digital self-test feature is provided to enable system-level diagnostics. The self-test function electromechanically excites the sensor to verify proper operation.

The 35.6 mm  $\times$  42.4 mm (plus mounting extensions) package provides the convenience of a standard geometry 24-pin interface and four mounting holes for simple installation. Consult the factory for additional dynamic range and sensitivity options.



### FUNCTIONAL BLOCK DIAGRAM

#### Rev. A

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### **REVISION HISTORY**

| 11/06—Rev. 0 to Rev. A            |   |
|-----------------------------------|---|
| Changes to Specifications Section |   |
| Added Figure 13                   | 8 |
| 7/06—Revision 0: Initial Version  |   |

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### **SPECIFICATIONS**

@  $T_A = 25^{\circ}$ C, VCC = 5 V, angular rate = 0°/sec,  $C_{OUT} = 0 \mu$ F, ±1 g, unless otherwise noted.

#### Table 1.

| Parameter   | Conditions  | Min <sup>1</sup> | Тур   | Max <sup>1</sup> | Unit            |
|---|---|------------------|-------|------------------|-----------------|
| SENSITIVITY   | Clockwise rotation is positive output                 |                  |       |                  |                 |
| Dynamic Range <sup>2</sup>  | Full-scale range over specified operating conditions  |                  |       |                  | degrees/sec     |
| Initial   | @ 25°C  |                  | 5     | 5.05             | mV/degrees/sec  |
| Over Temperature <sup>3</sup>   |   |                  | 5     | 5.25             | mV/degrees/sec  |
| Nonlinearity  | Best fit straight line                                |                  | 0.04  |                  | % of FS         |
| NULL  |   |                  |       |                  |                 |
| Initial Null  |   | 2.49             | 2.50  | 2.51             | V               |
| Over Temperature  | $V_s = 4.75 V$ to 5.25 V                              | 2.4              |       | 2.6              | V               |
| In Run Bias Stability   | 1σ, @ 25°C  |                  | 0.005 |                  | degrees/sec     |
| Angle Random Walk   | 1σ, @ 25°C  |                  | 0.9   |                  | degrees/sec/√Hz |
| Turn-On Time  | Power on to ±0.5°/sec of final value, 80 Hz bandwidth |                  | 35    |                  | ms              |
| Linear Acceleration Effect  | Any axis  |                  | 0.05  |                  | degrees/sec/g   |
| Voltage Sensitivity   | VCC = 4.75 V to 5.25 V                                |                  | 0.4   |                  | degrees/sec/V   |
| NOISE PERFORMANCE   |   |                  |       |                  |                 |
| Rate Noise Density⁴   | @ 25℃   |                  | 0.015 | 0.020            | degrees/sec/√Hz |
| FREQUENCY RESPONSE  |   |                  |       |                  |                 |
| 3 dB Bandwidth⁵   | No external capacitance                               |                  | 320   |                  | Hz              |
| Sensor Resonant Frequency   |   |                  | 14    |                  | kHz             |
| SELF-TEST INPUTS  |   |                  |       |                  |                 |
| ST RATEOUT Response <sup>6</sup>  | ST pin from Logic 0 to Logic 1                        | 175              | 270   | 365              | mV              |
| Logic 1 Input Voltage   | Standard high logic level definition                  | 3.3              |       |                  | V               |
| Logic 0 Input Voltage   | Standard low logic level definition                   |                  |       | 1.7              | V               |
| Input Impedance   | To common   |                  | 3.13  |                  | kΩ              |
| TEMPERATURE SENSOR  |   |                  |       |                  |                 |
| V <sub>оит</sub> at 298 К   |   |                  | 2.50  |                  | V               |
| Max Current Load on Pin   | Source to common                                      |                  |       | 50               | μΑ              |
| Scale Factor  | Proportional to absolute temperature                  |                  | 8.4   |                  | mV/K            |
| OUTPUT DRIVE CAPABILITY   |   |                  |       |                  |                 |
| Output Voltage Swing  | $I_{OUT} = \pm 1 \text{ mA}$                          | 0.25             |       | $V_{s} - 0.25$   | V               |
| Capacitive Load Drive <sup>7</sup>  |   | 1000             |       |                  | pF              |
| 2.5 V REFERENCE   |   |                  |       |                  |                 |
| Voltage Value   |   | 2.45             | 2.5   | 2.55             | V               |
| Load Drive to Ground  | Source  |                  | 150   |                  | μA              |
| Load Regulation   | 0 μA< Ι <sub>ουτ</sub> < 200 μA                       |                  | 5     |                  | mV/mA           |
| Power Supply Rejection  | 4.75 V <sub>s</sub> to 5.25 V <sub>s</sub>            |                  | 1     |                  | mV/V            |
| Temperature Drift   | Delta from 25°C                                       |                  | 5     |                  | mV              |
| POWER SUPPLY  |   |                  |       |                  |                 |
| Operating Voltage Range   |   | 4.75             | 5.00  | 5.25             | V               |
| Quiescent Supply Current $I_{OUT} = 0 \text{ mA}, +5 \text{ V}, 25^{\circ}\text{C}$ |   |                  | 95    | 110              | mA              |
| TEMPERATURE RANGE   |   |                  |       |                  |                 |
| Specified Performance Grade A   | Temperature tested to max and min specifications      | -40              |       | +85              | °C              |

<sup>1</sup> All minimum and maximum specifications are guaranteed. Typical specifications are not tested or guaranteed.

<sup>2</sup> Dynamic range is the maximum full-scale measurement range possible, including output swing range, initial offset, sensitivity, offset drift, and sensitivity drift at 4.75 V to 5.25 V supplies.

<sup>3</sup> Specification refers to the maximum extent of this parameter as a worst-case value of T<sub>MIN</sub> or T<sub>MAX</sub>, along with long-term effects.
<sup>4</sup> Resulting bias stability is <0.01°/sec.</li>

<sup>5</sup> Frequency at which response is 3 dB from dc response. See the Setting the Bandwidth section for adjusting this value.

<sup>6</sup> Self-test response varies with temperature.

<sup>7</sup> The value offered herein assures stability in the output buffer amplifier stage and no degradation of other specified performance parameters.

### **ABSOLUTE MAXIMUM RATINGS**

#### Table 2.

| Parameter   | Rating           |
|---|------------------|
| Acceleration (Any Axis, Unpowered, 0.5 ms)        | 2000 g           |
| Acceleration (Any Axis, Powered, 0.5 ms)          | 2000 g           |
| +Vs   | –0.3 V to +6.0 V |
| Output Short-Circuit Duration (Any Pin to Common) | Indefinite       |
| Operating Temperature Range                       | −55°C to +125°C  |
| Storage Temperature Range                         | –65°C to +150°C  |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Drops onto hard surfaces can cause shocks of greater than 2000 *g* and exceed the absolute maximum rating of the device. Care should be exercised in handling to avoid damage.

### THERMAL RESISTANCE

The ADIS16120 provides a temperature output that is representative of the junction temperature. This can be used for system-level monitoring and power management/thermal characterization.

#### **Table 3. Thermal Characteristics**

| Package Type  | θ <sub>JA</sub> | θ」       | Weight             |
|---------------|-----------------|----------|--------------------|
| 24-Pin Module | 15.7°C/W        | 1.48°C/W | 28.5 grams typical |

### **RATE SENSITIVE AXIS**

This is a z-axis rate sensing device that is also called a yaw rate sensing device. It produces a positive-going change in the output voltage as a result of clockwise rotation about the axis, normal to the package top; that is, clockwise when looking down at the package lid.

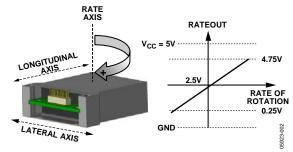


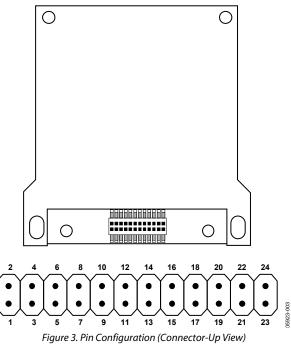
Figure 2. Rotational Measurement Orientation

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**



#### Table 4. Pin Function Descriptions

|         | Table 4. Fin Function Descriptions |  |  |  |  |  |  |
|---------|------------------------------------|--|--|--|--|--|--|
| Pin No. | Mnemonic                           | Description  |  |  |  |  |  |
| 1       | ST                                 | Self-Test.   |  |  |  |  |  |
| 2       | ST                                 | Self-Test.   |  |  |  |  |  |
| 3       | ST                                 | Self-Test.   |  |  |  |  |  |
| 4       | ST                                 | Self-Test.   |  |  |  |  |  |
| 5       | ST                                 | Self-Test.   |  |  |  |  |  |
| 6       | ST                                 | Self-Test.   |  |  |  |  |  |
| 7       | ST                                 | Self-Test.   |  |  |  |  |  |
| 8       | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 9       | ST                                 | Self-Test.   |  |  |  |  |  |
| 10      | TEMPOUT                            | Temperature Sensor Output.   |  |  |  |  |  |
| 11      | DNC                                | Do Not Connect.  |  |  |  |  |  |
| 12      | REFOUT                             | Reference Voltage.   |  |  |  |  |  |
| 13      | VCC                                | Power Supply.  |  |  |  |  |  |
| 14      | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 15      | VCC                                | Power Supply.  |  |  |  |  |  |
| 16      | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 17      | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 18      | RATEOUT                            | Angular Rate Output Signal.  |  |  |  |  |  |
| 19      | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 20      | FILTER                             | Filter Input. This is used in conjunction with RATEOUT; see the Setting the Bandwidth section for use. |  |  |  |  |  |
| 21      | DNC                                | Do Not Connect.  |  |  |  |  |  |
| 22      | DNC                                | Do Not Connect.  |  |  |  |  |  |
| 23      | СОМ                                | Power Supply Ground.   |  |  |  |  |  |
| 24      | DNC                                | Do Not Connect.  |  |  |  |  |  |
|         |                                    | · · · · · · · · · · · · · · · · · · ·  |  |  |  |  |  |

## **TYPICAL PERFORMANCE CHARACTERISTICS**

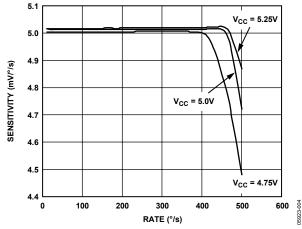
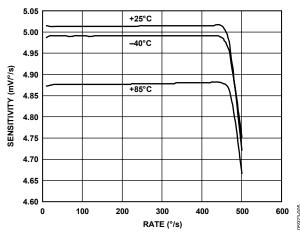
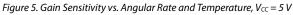
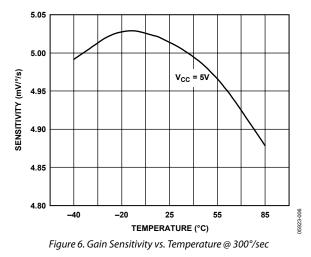
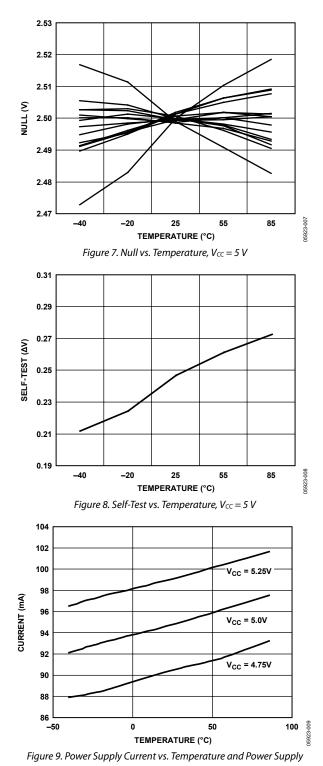


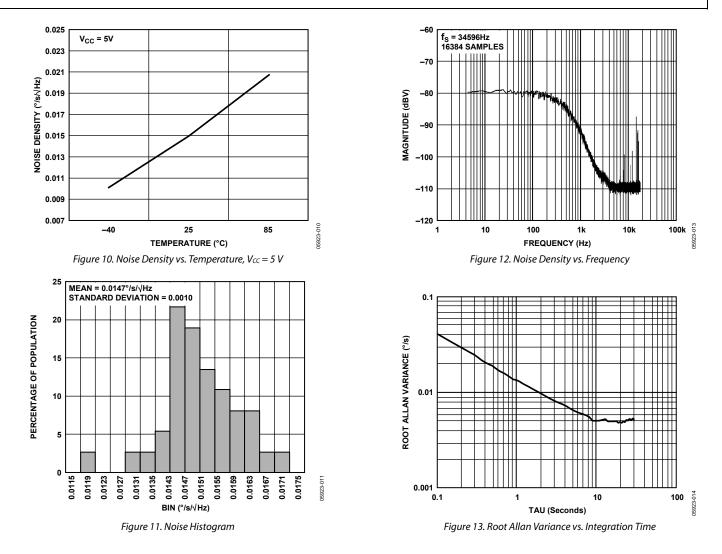
Figure 4. Gain Sensitivity vs. Angular Rate and Power Supply











### THEORY OF OPERATION

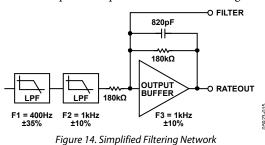
The base sensor in the ADIS16120 operates on the principle of a resonator gyroscope. Two polysilicon sensing structures each contain a dither frame that is electrostatically driven to resonance. This produces the necessary velocity element that creates a Coriolis force during angular motion. At the two outer extremes of each frame, orthogonal to the dither motion, are movable fingers that are placed between fixed fingers to form a capacitive pickoff structure that senses Coriolis acceleration. The resulting signal is fed to a series of gain and demodulation stages that produce the representative rate signal output. One advantage of the core dual-sensor design approach is that it provides improved rejection of external g-forces and vibration.

The ADIS16120 signal conditioning circuit provides an optimized filtering network that controls the resonators influence on noise while supporting a nominal bandwidth of 320 Hz. Another feature that helps reduce sensitivity to power supply noise is the integration of approximately 1.8  $\mu$ F of decoupling capacitance inside the ADIS16120.

The offset and sensitivity performance is factory calibrated and the internal reference voltage used in this calibration process is offered for external use. A temperature sensor is also provided for system level use, where appropriate.

### SETTING THE BANDWIDTH

An important trade-off in angular rate measurement applications is the one between total system noise and bandwidth. The ADIS16120 offers the flexibility to optimize this trade-off at the system level. The signal processing circuit of the ADIS16120 provides a three-pole, low-pass filter, as shown in Figure 14.



The bandwidth of the third stage can be reduced by installing a single capacitor across the RATEOUT and FILTER pins. Figure 15 provides a relationship for selecting the appropriate capacitor value and Table 5 provides bandwidth estimates for standard capacitor values.

The initial bandwidth of the ADIS16120 is dominated by the first stage and is dependent on the process variation of the base sensor. By reducing the bandwidth of the third filter stage, the influence of the first stage is reduced, and tighter bandwidth tolerances can be achieved.

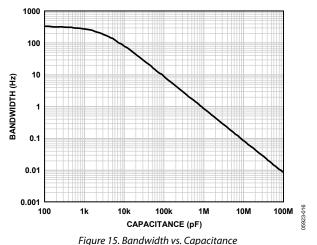


Table 5. Nominal Bandwidth for Standard Capacitor Values

| Table 5. Nominiar Dandwidth for Standard Capacitor Values |         |        |         |  |  |
|---|---------|--------|---------|--|--|
| C (pF)  | BW (Hz) | C (pF) | BW (Hz) |  |  |
| 1000  | 267.3   | 10,000 | 78.4    |  |  |
| 1200  | 256.2   | 12,000 | 67.1    |  |  |
| 1500  | 244.1   | 15,000 | 55.2    |  |  |
| 1800  | 225.5   | 18,000 | 46.4    |  |  |
| 2200  | 211.9   | 22,000 | 38.8    |  |  |
| 2700  | 192.3   | 27,000 | 31.8    |  |  |
| 3300  | 173.2   | 33,000 | 26.2    |  |  |
| 3900  | 156.4   | 39,000 | 22.2    |  |  |
| 4300  | 148.9   | 43,000 | 20.2    |  |  |
| 4700  | 140.4   | 47,000 | 18.5    |  |  |
| 5100  | 132.9   | 51,000 | 17.1    |  |  |
| 5600  | 124.5   | 56,000 | 15.6    |  |  |
| 6200  | 115.6   | 62,000 | 14.1    |  |  |
| 7500  | 99.0    | 75,000 | 11.7    |  |  |
| 8200  | 92.7    | 82,000 | 10.7    |  |  |
| 9100  | 85.5    | 91,000 | 9.6     |  |  |

### **SELF-TEST FUNCTION**

The ADIS16120 provides a self-test function that exercises the mechanical structure of the sensor. To use this function, Pin 1 to Pin 7 and Pin 9 must be tied together and driven to a high logic state to activate this function. A continuous self-test does not damage the device.

### APPLICATIONS ACHIEVING OPTIMAL NOISE PERFORMANCE

There are several system level considerations that can have an impact on the noise and accuracy of the ADIS16120. Understanding and managing these factors can influence the behavior of any high performance system.

### Supply and Common Considerations

The ADIS16120 provides approximately 1.8  $\mu$ F of decoupling capacitance. This capacitance is distributed throughout the device and should be taken into account when considering potential noise threats on the power supply lines.

### **Reference Output**

The same reference that is used to calibrate the offset performance of the ADIS16120 is made available for system level use. This pin has 1  $\mu$ F of capacitance, providing a degree of noise filtering. However, careful use of this pin is necessary considering that any noise or level-shifting influences introduce errors in the output.

### **Bandwidth Setting**

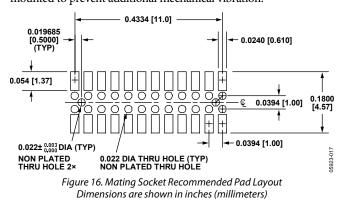
If  $C_{OUT}$  is applied to reduce the bandwidth of the ADIS16120's response, it should be placed close to the device. Long cable leads and PCB traces can increase the risk of noise introduction.

### USING THE ADIS16120 WITH A SUPPLY-RATIOMETRIC ADC

The RATEOUT signal of the ADIS16120 is nonratiometric, that is, neither the null voltage nor the rate sensitivity is proportional to the supply. Instead, they are nominally constant for dc supply changes within the 4.75 V to 5.25 V operating range. If the ADIS16120 is used with a supply-ratiometric ADC, the 2.5 V output of the ADIS16120 can be converted and used to make corrections in software for the supply variations.

### SECOND LEVEL ASSEMBLY

The ADIS16120 is designed to be mounted with the header pins either facing up (bulkhead mount) or facing down (printed circuit board mount). In either case, the mating socket should be a Samtec P/N CLM-112-02-L-D-A or equivalent. This family of connectors offers multiple configurations for use in mating to the ADIS16120. Consult the manufacturers reference material if this connector does not match system level requirements. The recommended pad/hole layout for this socket can be found in Figure 16. Use the alignment pins identified in this figure, along with either Figure 17 or Figure 18, to design an appropriate interface for the ADIS16120. Note that in order to meet worst-case dimensional tolerances of the entire package, the header pins extend beyond the height of the package, requiring the mating printed circuit board (PCB) to have holes to prevent bottoming-out of the ADIS16120s pins. Without the holes, a bottom-out event would place the ADIS16120 under stress, which can affect accuracy performance. Also, in either mounting configuration, make sure that the ADIS16120 is firmly mounted to prevent additional mechanical vibration.



### **Bulkhead Mounting**

Figure 17 provides the hole locations and maximum size for the bulkhead mount option. When using the bulkhead mount option, the user can interface to the ADIS16120 header via a cable or an interface board/cable assembly. This assembly is not provided. Consult www.analog.com/isensor for the latest interface/evaluation board options.

Hole locations are provided in Figure 18 for the interface board. Hole locations for optional alignment posts are also shown in Figure 18. The hole shown in the interface board for the mounting screw clearance is sized to provide alignment flexibility. A washer is required under the screw head for these hole sizes.

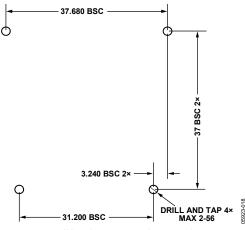


Figure 17. Bulkhead Mount Attachment Hole Locations

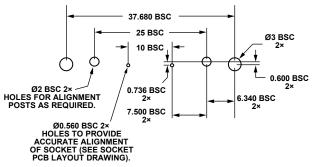


Figure 18. Interface Board Hole Locations for Bulkhead Mount

### Printed Circuit Board Mounting

Figure 19 shows the PCB mount hole locations for correct alignment. Hole locations for optional alignment posts are shown in this diagram.

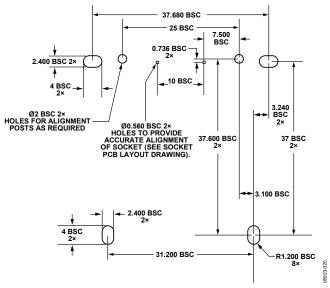


Figure 19. Printed Circuit Board Mounting Hole Pattern

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### **OUTLINE DIMENSIONS**

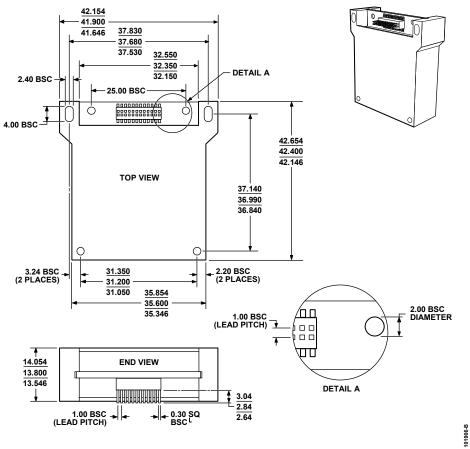


Figure 20. ADIS16120 PCB Module with Connector Interface (ML-24) Dimensions shown in millimeters

### **ORDERING GUIDE**

| Model         | Temperature Range | Package Description                 | Package Option |
|---------------|-------------------|-------------------------------------|----------------|
| ADIS16120AML  | –40°C to +85°C    | PCB Module with Connector Interface | ML-24          |
| ADIS16120/PCB |                   | Evaluation Board                    |                |

### NOTES

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